

Supporting Information

Hole Defects and Nitrogen Doping in Graphene: Implication for Supercapacitor Applications

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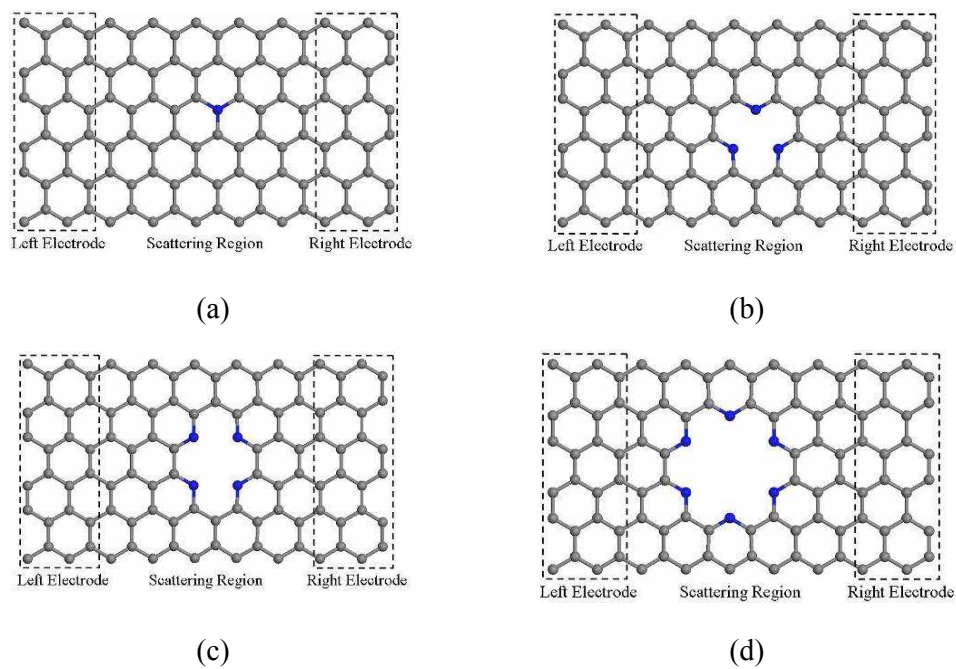


Figure S1 Illustration of the graphene-based devices for transport calculations including left/right electrode and central scattering region: (a) quaternary-like, pyridinic-like with (b) triangular, (c) rectangular, (d) hexagonal hole shapes.

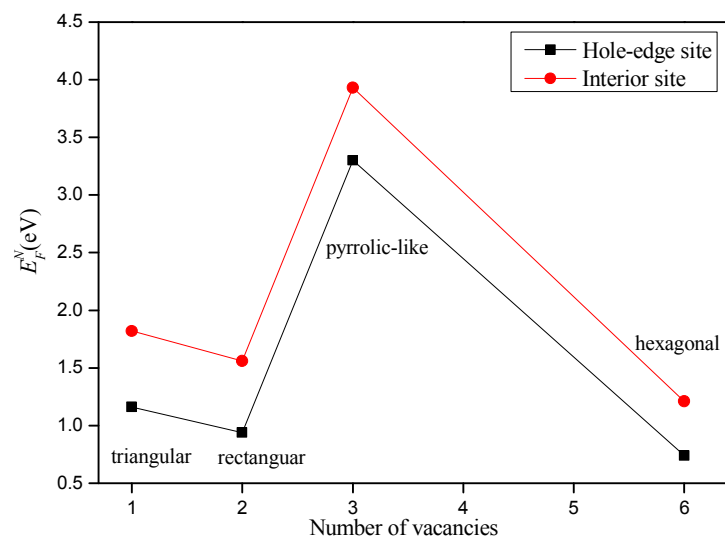


Figure S2 Formation energy of nitrogen doping (E_F^N) for hole edge or interior site with different hole shapes.

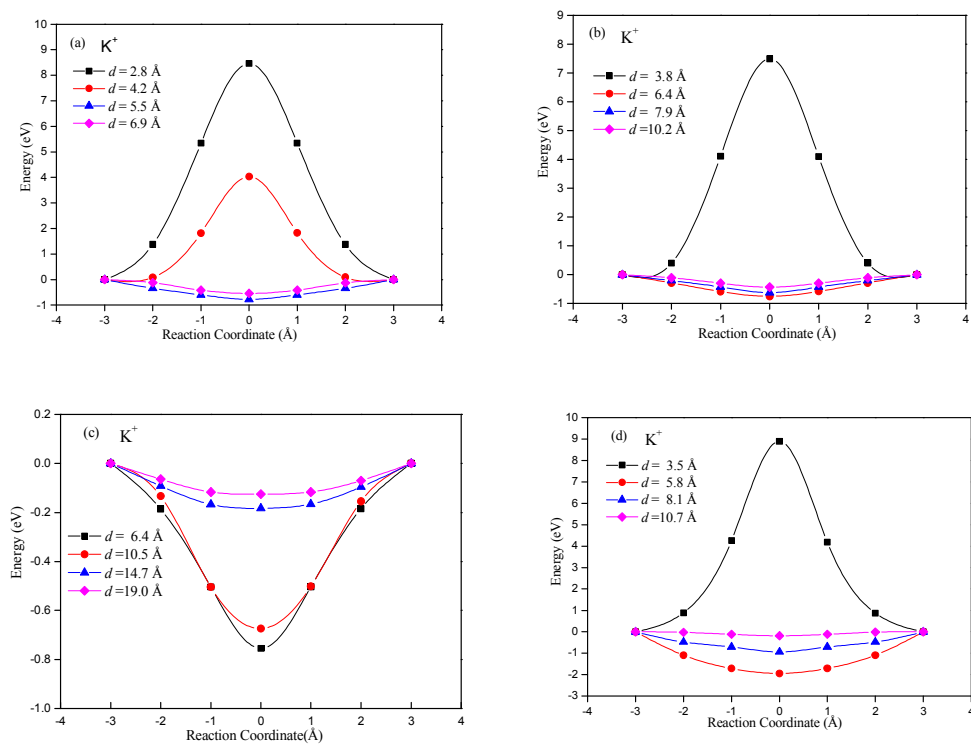


Figure S3 Diffusion barriers for K^+ ions passing through the undoped graphene with different hole sizes: (a) triangular, (b) rectangular, and (c) hexagonal holes for pyridinic-like holes; (d) pyrrolic-like holes.

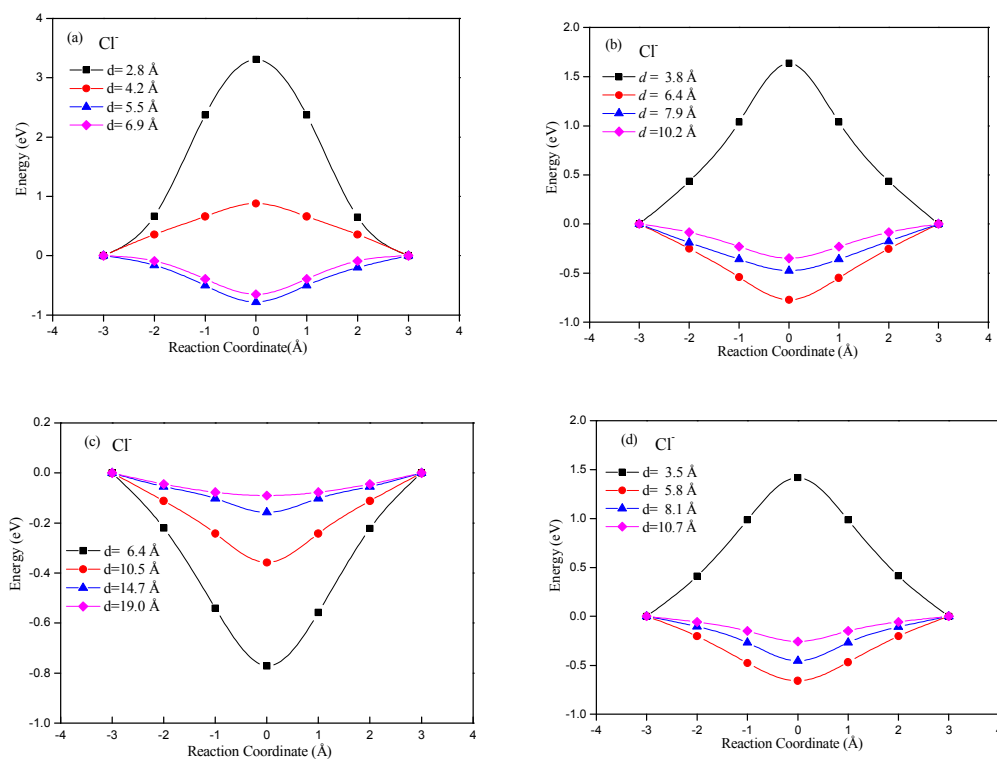


Figure S4 Diffusion barriers for Cl^- ions passing through the undoped graphene with different hole sizes: (a) triangular, (b) rectangular, and (c) hexagonal holes for pyridinic-like holes; (d) pyrrolic-like holes.

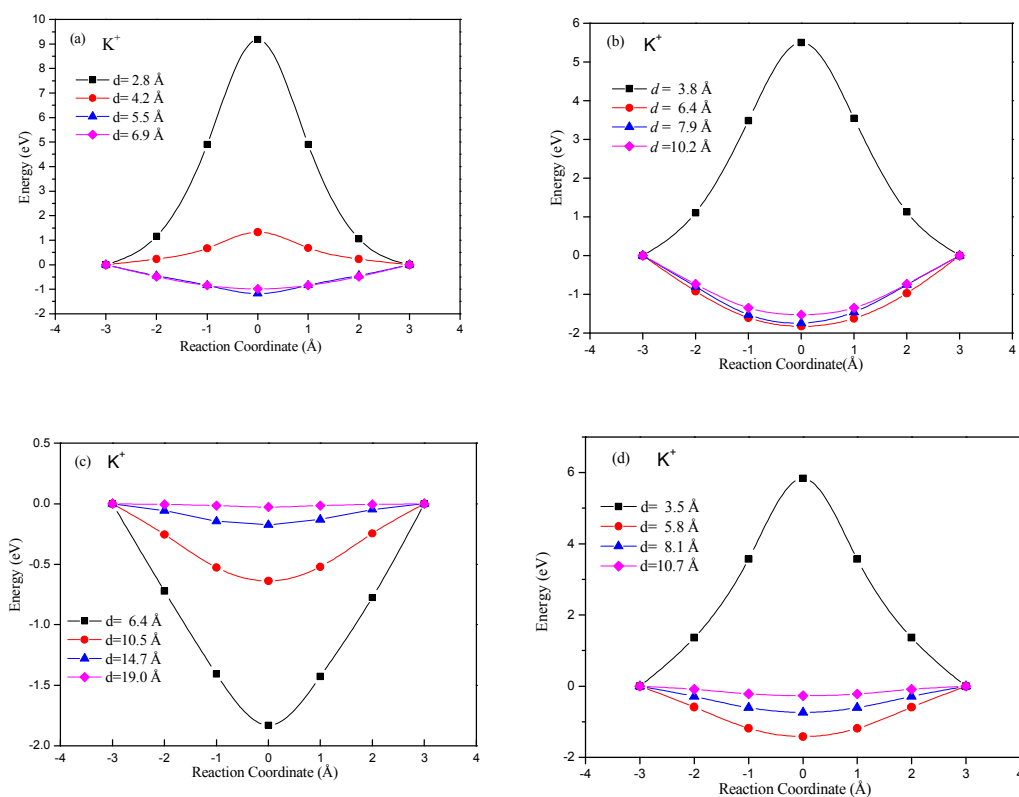


Figure S5 Diffusion barriers for the K^+ ions passing through the N-doped graphene with different hole sizes: (a) triangular, (b) rectangular, and (c) hexagonal holes for pyridinic-like holes; (d) pyrrolic-like holes.

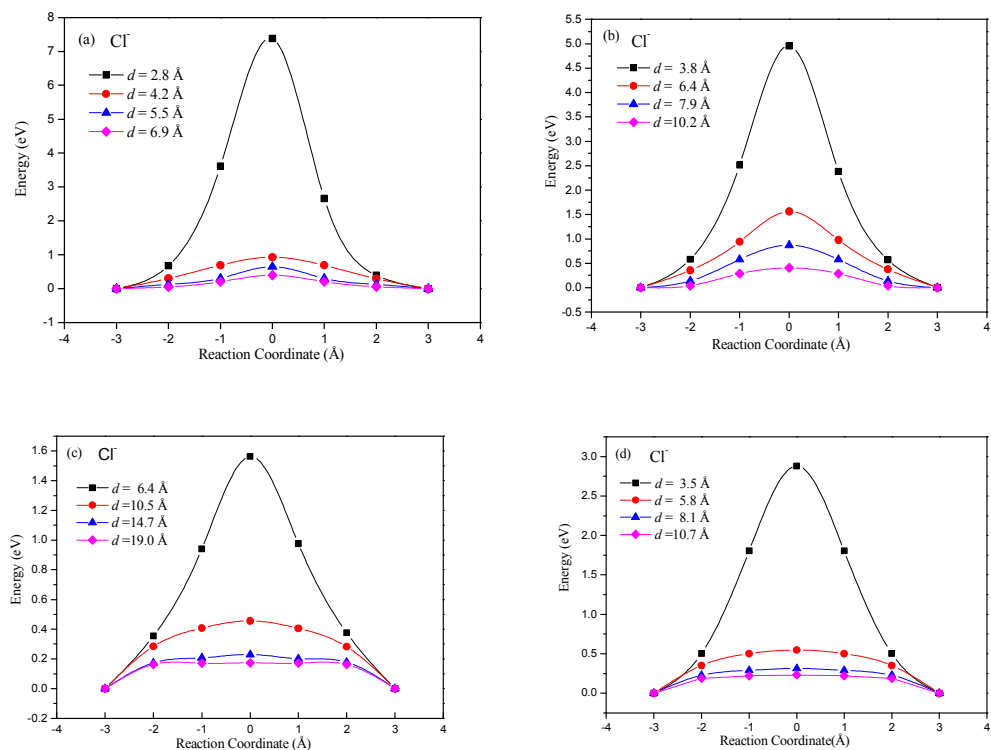


Figure S6 Diffusion barriers for Cl^- ions passing through the N-doped graphene with different hole sizes: (a) triangular, (b) rectangular, and (c) hexagonal holes for pyridinic-like holes; (d) pyrrolic-like holes.

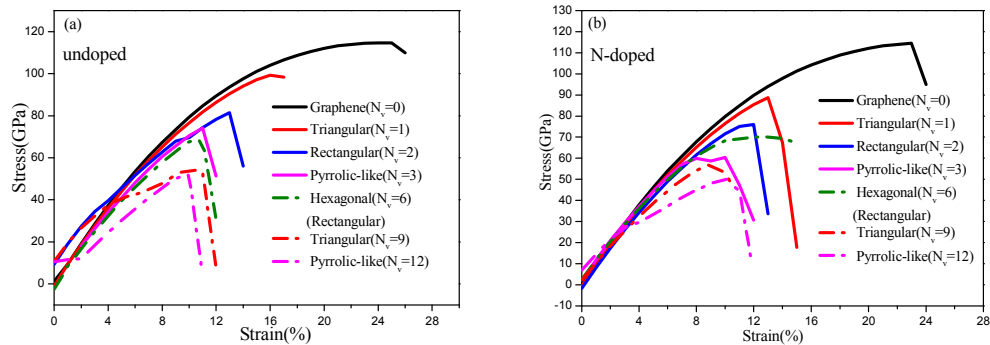


Figure S7 Stress-strain curves of (a) undoped and (b) N-doped graphene sheets. The intrinsic strength is defined as the critical point beyond which the stress decreases with strain.

Table S1. Activation energies (eV) of K^+ and Cl^- ions with different solvent in the N doped hexagonal holes for pyridinic-like systems.

	Vacuum				Acetonitrile ($\epsilon = 37.5$)				H_2O ($\epsilon = 78.54$)			
$d(\text{\AA})$	6.4	10.5	14.7	19.0	6.4	10.5	14.7	19.0	6.4	10.5	14.7	19.0
K^+	-1.78	-0.68	-0.23	-0.08	-0.79	-0.16	-0.01	-0.004	-0.77	-0.18	-0.06	-0.002
Cl^-	1.11	0.24	0.07	0.02	1.10	0.20	0.008	0.003	1.11	0.19	0.004	0.02